

UNISONIC TECHNOLOGIES CO., LTD

F5N50 Power MOSFET

5A, 500V N-CHANNEL POWER MOSFET

DESCRIPTION

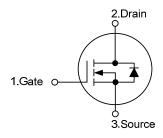
The UTC **F5N50** is an N-channel power MOSFET adopting UTC's advanced technology to provide customers with DMOS, planar stripe technology. This technology is designed to meet the requirements of the minimum on-state resistance and perfect switching performance. It also can withstand high energy pulse in the avalanche and communication mode.

The UTC **F5N50** can be used in applications, such as active power factor correction, high efficiency switched mode power supplies, electronic lamp ballasts based on half bridge topology.

■ FEATURES

- * $R_{DS(ON)}$ < 1.6 Ω @ V_{GS} =10V, I_{D} =2.5A
- * 100% avalanche tested
- * High switching speed

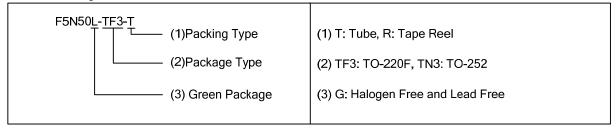
■ SYMBOL



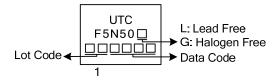
■ ORDERING INFORMATION

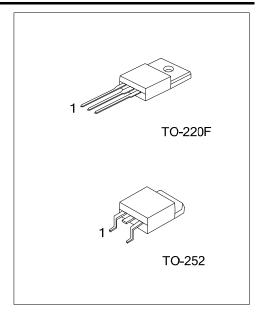
Ordering Number		Doolsono	Pin Assignment			Dealing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
F5N50L-TF3-T	F5N50G-TF3-T	TO-220F	G	D	S	Tube	
F5N50L-TN3-R	F5N50G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING





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F5N50 Power MOSFET

■ **ABSOLUTE MAXIMUM RATINGS** (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	500	V	
Gate-Source Voltage		V _{GSS}	±30	V	
Drain Current	Continuous	I_{D}	5	А	
	Pulsed (Note 2)	I_{DM}	20	Α	
Avalanche Current (Note 2)		I _{AR}	5	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	200	mJ	
	Repetitive (Note 2)	E _{AR}	7.3	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation	TO-220F	J	38	W	
	TO-252	P_D	54	W	
Junction Temperature		T_J	+150	°C	
Storage Temperature		T _{STG}	-55~+150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 16mH, I_{AS} = 5A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 4. $I_{SD} \le 5A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220F	0	62.5	°C/W
	TO-252	θ_{JA}	110	°C/W
Junction to Case	TO-220F	θυς	3.25	°C/W
	TO-252		2.13	°C/W

F5N50

■ **ELECTRICAL CHARACTERISTICS** (T_C=25°C, unless otherwise specified)

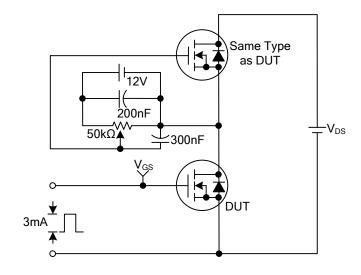
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV_{DSS}	I _D =250μA, V _{GS} =0V	500			V
Breakdown Voltage Temperature Coefficient		$\triangle BV_{DSS}/\triangle T_{J}$	Reference to 25°C, I _D =250µA		0.5		V/°C
Drain Course Leakens Current			V _{DS} =500V, V _{GS} =0V			1	
Drain-Source Leakage Current		I _{DSS}	V _{DS} =400V, T _C =125°C			10	μΑ
Gate- Source Leakage Current	Forward	- I _{GSS}	V _{GS} =30V, V _{DS} =0V			100	nA
	Reverse		V _{GS} =-30V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	1.5		3.5	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =2.5A		1.25	1.6	Ω
DYNAMIC PARAMETERS							
Input Capacitance	ut Capacitance				480	625	pF
Output Capacitance		C _{ISS}	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		80	105	pF
Reverse Transfer Capacitance		C _{RSS}			15	20	pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_{G}	\/ -10\/ \/ -50\/		20	24	nC
Gate to Source Charge		Q_GS	V _{GS} =10V, V _{DS} =50V,		4		nC
Gate to Drain Charge		Q_GD	I _D =1.3A (Note 1, 2)		5		nC
Turn-ON Delay Time		$t_{D(ON)}$			30	50	ns
Rise Time		t_R	V_{DD} =30V, I_{D} =0.5A,		50	70	ns
Turn-OFF Delay Time		t _{D(OFF)}	R _G =25Ω (Note 1, 2)		145	100	ns
Fall-Time		t_{F}			70	105	ns
SOURCE- DRAIN DIODE RATIN	IGS AND CI	HARACTERIS	rics				
Maximum Continuous Drain-Source Diode Forward Current		Is				5	Α
						5	А
Maximum Pulsed Drain-Source Diode Forward Current		I _{SM}				20	Α
						20	
Drain-Source Diode Forward Voltage		V_{SD}	I _S =5A, V _{GS} =0V			1.4	V
Reverse Recovery Time		t _{rr}	I _S =5A, V _{GS} =0V,		120		ns
Reverse Recovery Charge		Q_{RR}	dI _F /dt=50A/μs (Note 1)		0.15		μC

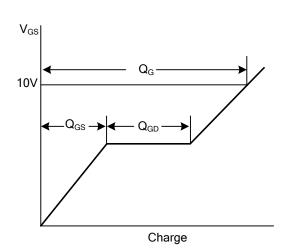
Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

^{2.} Essentially independent of operating temperature

F5N50 **Power MOSFET**

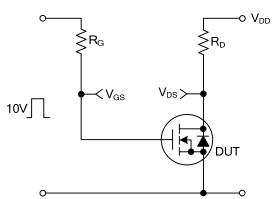
TEST CIRCUITS AND WAVEFORMS

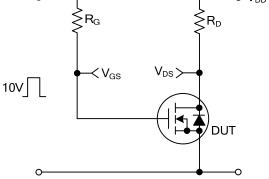


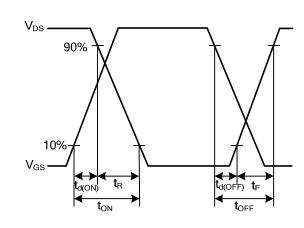


Gate Charge Test Circuit

Gate Charge Waveforms

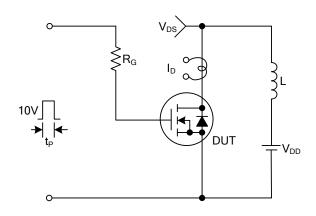


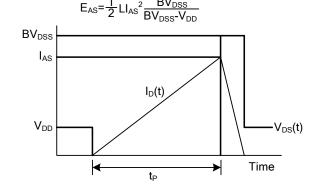




Resistive Switching Test Circuit

Resistive Switching Waveforms

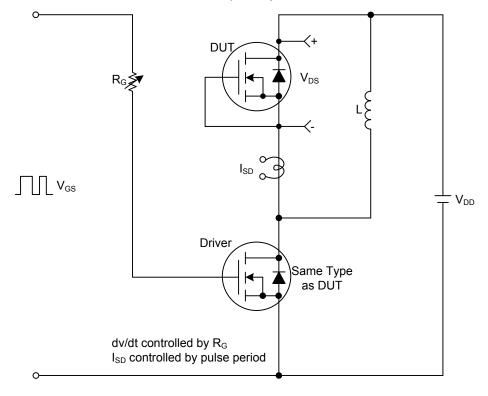




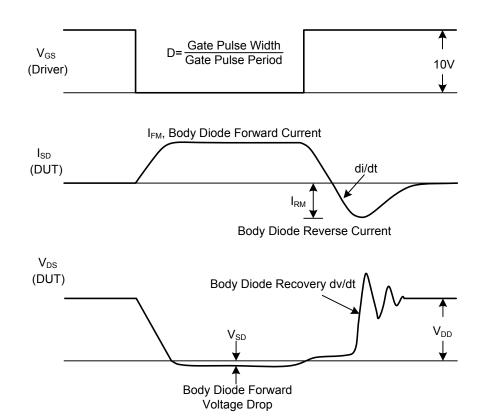
Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

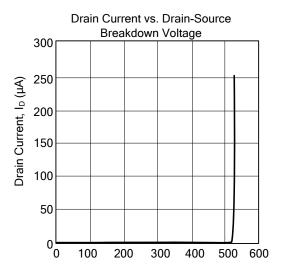
■ TEST CIRCUITS AND WAVEFORMS(Cont.)



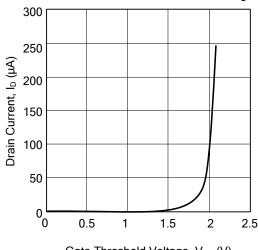
Peak Diode Recovery dv/dt Test Circuit & Waveforms



TYPICAL CHARACTERISTICS

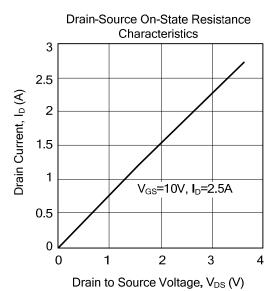


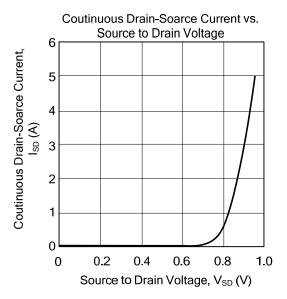
Drain-Source Breakdown Voltage, BV_{DSS} (V)



Drain Current vs. Gate Threshold Voltage

Gate Threshold Voltage, V_{TH} (V)





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